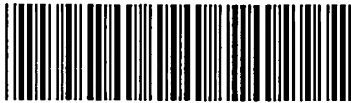


**Search Notes**

Application/Control No.

10/646,768

Examiner

Khanh V. Nguyen

Applicant(s)/Patent under  
Reexamination

YOKOYAMA, KENJI

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
330	10,207A,2 51	10/28/2004	NKV
363	41	10/28/2004	NKV
375	238	10/28/2004	NKV

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
CLASSES	ABOVE	7/1/2005	NKV

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	7/1/2005	NKV